

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Applicant(s): Finarov, Moshe
Assignee: Nova Measuring Instruments
Title: APPARATUS FOR OPTICAL INSPECTION OF WAFERS DURING POLISHING
Serial No.: 09/047,944 Filed: 03/25/98
Batch No.: S39 Date Allowed: April 27, 1999
Examiner: E. Morgan Group Art Unit: 3723
Docket No.: M-3417-1C US

San Jose, California
July 29, 1999

Box Issue Fee
Attn: Official Draftsperson
ASSISTANT COMMISSIONER FOR PATENTS
Washington, D. C. 20231

SUBMISSION OF FORMAL DRAWINGS

Dear Sir:

Applicant submits(7) sheets of formal drawings, consisting of Figures 1, 2, 3, 4, 5, 6, 7, 8, 9, 10, 11, 12, and 13, in the above-named application. If there are any questions regarding these drawings, please call the undersigned at (408) 453-9200.

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Assistant Commissioner for Patents, Washington, D.C. 20231, on July 29, 1999.

David W. Heid

Attorney for Applicant(s)

7/29/99

Date of Signature

Respectfully submitted,

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